

SPECIFICATION

Character Type STN Dot Matrix LCD Module

JM320240C

SHENZHEN JINGHUA DISPLAYS CO.,LTD



GENERAL SPECIFICATION

320 X 240 dot display

Samsung LCD driver: S6B2086X01

Interface with 8-bit MPU (directly connected to Z80 serial MPU)

Display Specification

Display Mode: graphic, text and combination text-graphic mode

Display Dot: 320 X 240

Display type: FSTN

Display color-Display background color: White

Polarizer mode:Positive. Transflective.

Viewing angle: 9:00

Display duty: 1/240

Driving bias: 1/16

Memory and External Memory:

A standard 160-word character generator ROM

64K external display RAM (static RAM)

Mechanical characteristics (Unit:mm)

Extenal dimension: 166*109*13.1

View area: 122.0*92.0

Dot size: 0.33*0.33

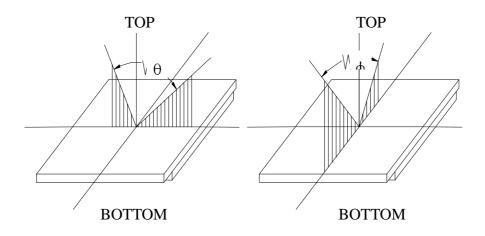
Dot pitch: 0.36*0.36

POWER: negative power;+5V power



• Optical Characteristics

(1) Definition of viewing Angle



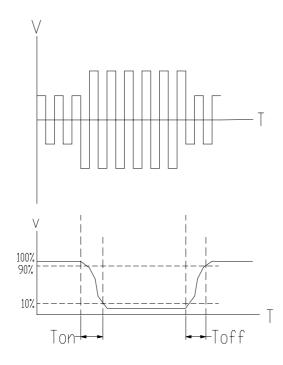
(2) Definition of Contrast Ratio:

 $Contrast \ Ratio = \frac{ \ \frac{Reflectance \ value \ of \ non-selected \ state \ brightness}{Reflectance \ value \ of \ selected \ state \ brightness} \ \ Test \ condition:$

standard A light source

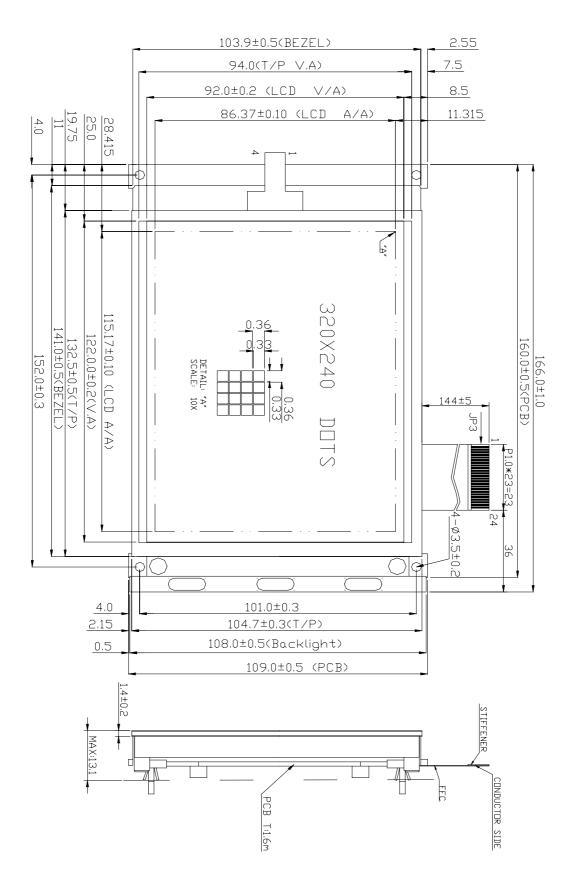
(3) Response Time

Response time is measured as the shortest period of time possible between the change in state of an LCD segment as demonstrated below



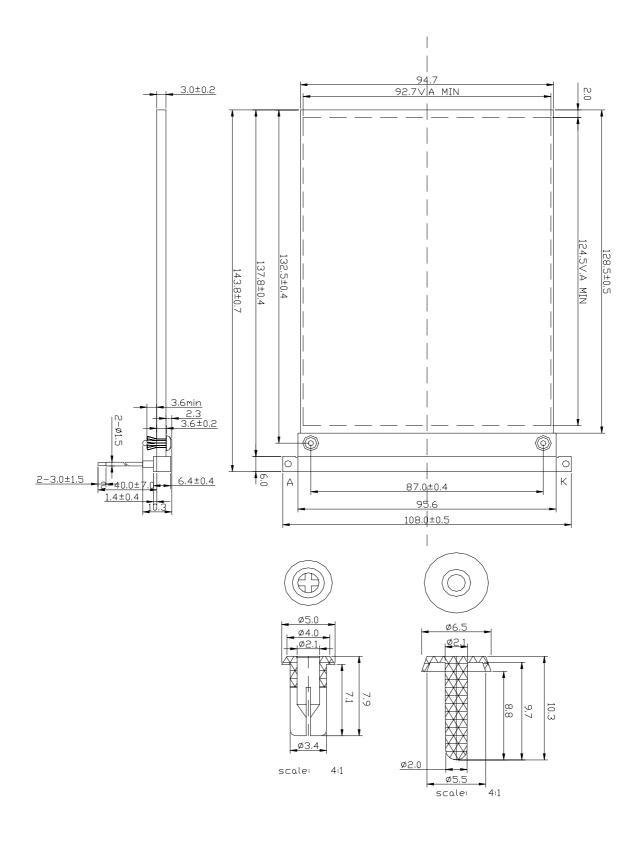


• External Dimension(For LED backlight and touch panel)



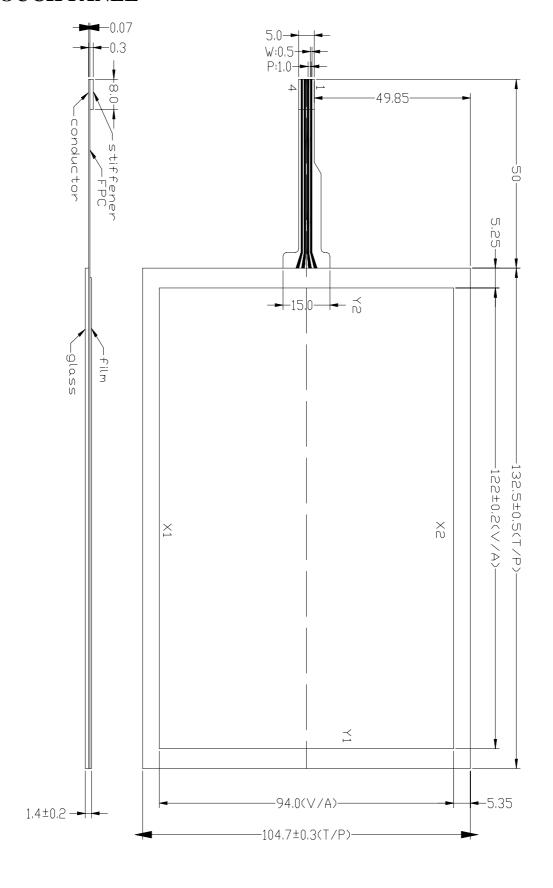


• External Dimension(For LED backlight)





• TOUCH PANEL





• LED Backlight

Electrical/Optical Specifications:

	Symbol	Min.	Тур.	Max.	Unit	Conditions
Forward Voltage	Vf	-	4.0	-	V	
Forward Current	If	-	90	120	mA	Vf=4.0V
Power Dissipation	Pd	-	0.36	-	W	Vf=4.0V
Reverse Vollage	Vr	1	5.0	-	V	
Reverse Current	Ir	1	1.2	-	mA	
Luminous Intensity	Iv	-	160.0	-	Cd/m2	
Luminous Uniformity	-	70	-	-	%	Vf=4.0V
Chromaticity Coordinate	-	X=0.298 Y=0.305	-	X=0.328 Y=0.335	-	
Emission Wavelength	λр	-	-	-	nm	If=15mA Ta=25℃
Spectral Range	Δλ	-	-	-	nm	Each Chip

Absolute Maximum Ratings At Ta=25 $^{\circ}\text{C}$

Parameter	Symbol	Specification.	Unit	Remark
Power Dissipation	Pad	360	mW	
Forward Current	Iaf	90	mA	
Reverse Voltage	Vr	5	V	
Operating Temperature	Topr	-30°C TO +85°C	${\mathbb C}$	
Storage Temperature	Tstg	-40℃ TO +100℃	\mathbb{C}	

Electrical/Optical Characteristics At Ta=25 $^{\circ}$ C

Parameter	Symbol	Min.	Тур.	Max.	Unit	Remark
Average Luminous Intensity	Iv	150	160		cd/m ²	Vf=4.0V
Luminous Intensity	-	70	-	-	%	
Charactisites Coordinate	X	0.29	0.3	0.31	ı	VIC 4 OV
Chrornaticity Coordinate	Y	0.26	0.3	0.33	-	Vf=4.0V
Forward Voltage	Vf	-	4.0	-	V	
Reverse Current	Ir	-	1.2	-	mA	



• Absolute Maximum Ratings

ITEM	Symbol	Min	Type	Max	Unit		
Oprating temperature	Тор	0	-	+50	${\mathcal C}$		
Storage temperature	Tst	-20	-	+70	${\mathcal C}$		
Input Voltage	Vi	-0.3	-	Vdd+0.3	V		
Supply voltage for Logic	Vdd-Vss	-0.3	-	+7.0	V		
Supply voltage for LCD	Vdd-V0	-0.3	-	+30.0	V		
Static electricity	Be sure that you are grounded when handing LCM						

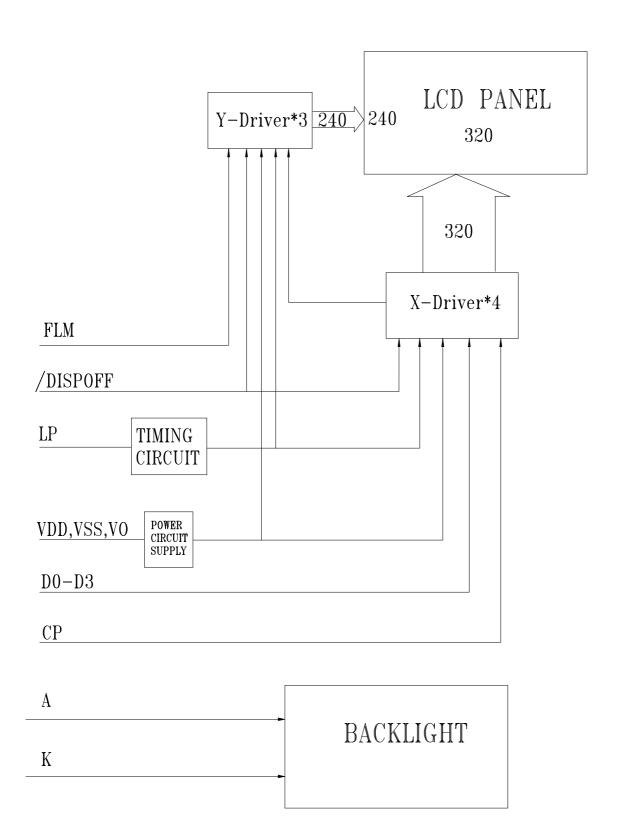
• **Electrical Characteristics** (Ta=25 °C, Vdd= 5.0V)

Item	Cymbol	Condition	Sta	ndard Valı	ue	Unit	
Item	Symbol	Condition	min	Type	max		
Supply Voltage for logic	Vdd-Vss	-	2.7	5.0	5.5	V	
Supply Voltage for LCD	Vdd-V0	-	-	24.0	-	V	
Input high voltage	Vih	-	0.8Vdd	-	Vdd	V	
Input low voltage	Vil	-	-	-	0.2Vdd	V	
Output high voltage	Vo _h	Ioh=0.4mA	Vdd-0.4	-	-	V	
Output high voltage	V_{ol}	Iol=0.4mA	-	-	0.4	V	
Supply Current for logic	*Idd	-	-	6	10	mA	
Frame frequency	FLM	-	35	-	150	Hz	
M signal frequency	Fm	-	35	-	150	Hz	

^{*}Idd Measurement condition is for all pixels on display.

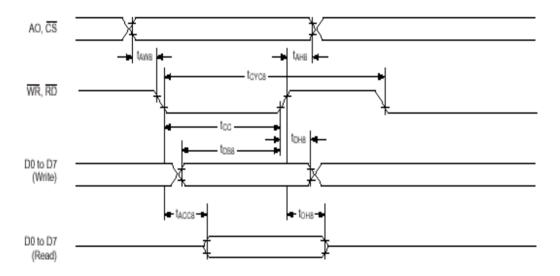


• Block Diagram





• 8080 family interface timing



 $Ta = -20 \text{ to } 75^{\circ}\text{C}$

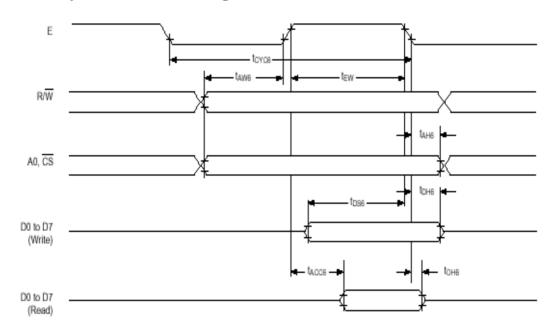
Cianal	Symbol	Parameter	V DD = 4.5	5 to 5.5V	V DD = 2.7	7 to 4.5V	Unit	Condition
Signal	Syllibol	raiailletei	min	max	min	max	5	Condition
A0, CS	tah8	Address hold time	10	I	10	1	ns	
AU, US	taw8	Address setup time	0	I	0	I	ns	
WR, RD	tCYC8	System cycle time	See note.	I	See note.	I	ns	
WK, KD	tcc	Strobe pulsewidth	120	I	150	1	ns	CL = 100pF
	tDS8	Data setup time	120	ı	120	1	ns	OL - 100pi
D0 to D7	tDH8	Data hold time	5	I	5	ı	ns	
יום טו טם	tACC8	RD access time	-	50	-	80	ns	
	ton8	Output disable time	10	50	10	55	ns	

Note: For memory control and system control commands:

For all other commands:



• 6800 family interface timing



Note: toyos indicates the interval during which CS is LOW and E is HIGH.

 $Ta = -20 \text{ to } 75^{\circ}C$

Signal	Symbol	Parameter	V DD = 4.5	5 to 5.5V	V DD = 2.7	7 to 4.5V	Unit	Condition
Signal	Syllibol	rarameter	min	max	min	max	OIIIL	Condition
A0,	tCYC6	System cycle time	See note.	I	See note.	1	ns	
A0, CS,	tAW6	Address setup time	0	I	10	1	ns	
R/W	tAH6	Address hold time	0	I	0	1	ns	
	tDS6	Data setup time	100	-	120	1	ns	CL =
D0 to D7	tDH6	Data hold time	0	-	0	1	ns	100 pF
D0 10 D7	ton6	Output disable time	10	50	10	75	ns	
	tACC6	Access time	_	85		130	ns	
Е	tEW	Enable pulsewidth	120	-	150	_	ns	

Note: For memory control and system control commands:

 $t_{CYC6} = 2t_C + t_{EW} + t_{CEA} + 75 > t_{ACV} + 245$

For all other commands:

t_{CYC6} = 4t_C + t_{EW} + 30



• AC CHARACTERISTICS

(1) SEGMENT DRIVER APPLICATION

 $(Vss = 0 V, Ta = -30 \sim +85^{\circ}C)$

Characteristic	Combal	Test	(1) VI	DD=5 V ±	10%	(2) VI	D=3 V ±	10%	I I a M
Characteristic	Symbol	Condition	MIN	TYP	MAX	MIN	TYP	MAX	Unit
Clock cycle time	t _{CY}	Duty=50%	125	-	-	250	-	-	
Clock pulse width	t _{WCK}	-	45	-	-	95	-	-	
Clock rise/fall time	$t_{R/tF}$		-	-	-	-	-	30	
Data set-up time	t _{DS}	-	30	-	-	65	-	-	
Data hold time	t _{DH}		30	-	-	65	-	-	
Clock set-up time	t _{CS}	-	80	-	-	120	-		ns
Clock hold time	t _{CH}	-	80	-	-	120	-	-	
Propagation delay time	t _{PHL}	ELB Output		60		125]		
Propagation delay time		ERB Output			60	•		125	
ELB,ERB set-up time	t _{PSU}	ELB Input	30			65			
EEB,END Set-up time	420	ERB Input	30			65		-	
DISPOFFB low pulse width	t_{WDL}		1.2	•	-	1.2	•	-	μs
DISPOFFB clear time	t _{CD}		100	-	-	100	-		ns
M - OUT propagation delay time	t _{PD1}				1.0	-		1.2	
CL1 - OUT propagation delay time	t _{PD2}	CL=15 pF			1.0			1.2	μs
DISPOFFB - OUT propa- gation delay time	t _{PD3}				1.0			-	



• AC CHARACTERISTICS(CONTINUED)

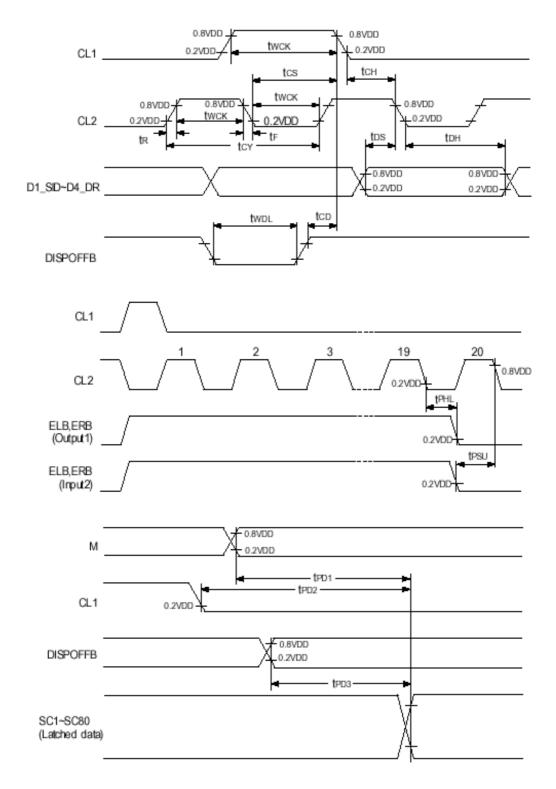
(2) COMMON DRIVER APPLICATION

Characteristic	Symbol	Test	(1) VI	DD=5 V ±	10%	(2) V	DD=3V±	10%	Unit
Characteristic	Symbol	Condition	MIN	TYP	MAX	MIN	TYP	MAX	o iii
Clock cycle time	t _{CY}	Duty=50%	250			500			
Clock pulse width	twck		45	-		95			
Clock rise/fall time	t _{R/tF}		-		50			50	ns
Data set-up time	t _{DS}		30			65			
Data hold time	t _{DH}		30			65			
DISPOFFB low pulse width	t _{WDL}		1.2			1.2			μs
DISPOFFB clear time	tco		100			100			ne
Output delay time	t _{DL}		-		200			250	ns
M - OUT propagation delay time	t _{PD1}				1.0			1.2	
CL1 - OUT propagation delay time	t _{PD2}	CL=15 pF			1.0			1.2	μs
DISPOFFB - OUT propagation delay time	t _{PD3}				1.0			1.2	



• AC CHARACTERISTICS(CONTINUED)

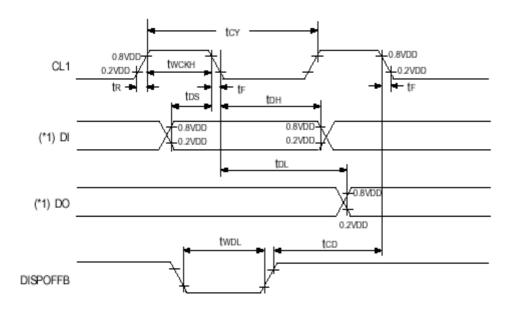
(3) SEGMENT DRIVER APPLICATION TIMING





• AC CHARACTERISTICS(CONTINUED)

(4) COMMON DRIVER APPLICATION TIMING



(*1) When in single-type interface mode

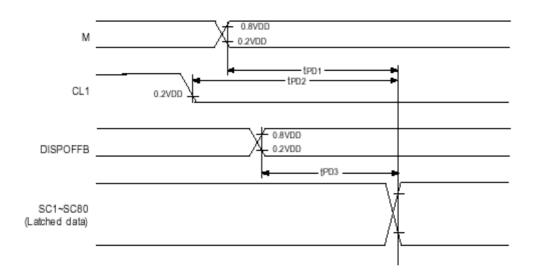
DI ⇒ D2_DL(SHL="L"), D4_DR(SHL="H")

DO ⇒ D4_DR(SHL="L"), D2_DL(SHL="H")

When in dual-type interface mode

DI ⇒ D2_DL and D3_DM(SHL="L"), D4_DR and D3_DM(SHL="H")

DO ⇒ D4_DR(SHL="L"), D2_DL(SHL="H")

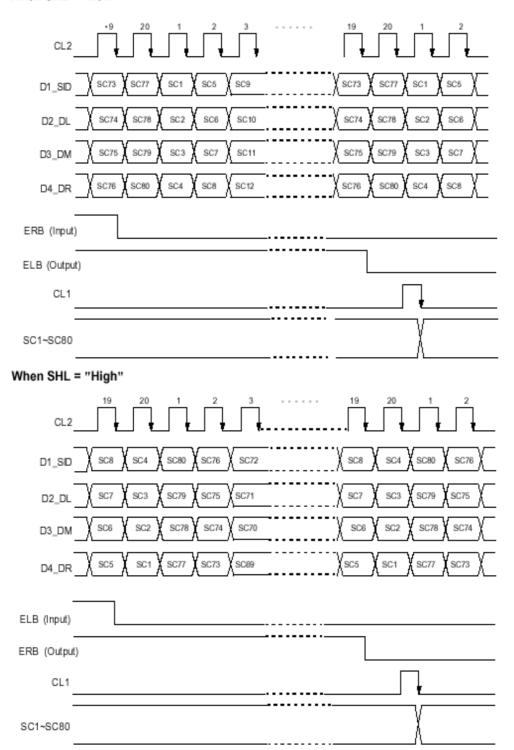




• OPERATION TIMING DIAGRAM

4-BIT PARALLEL MODE INTERFACE SEGMENT DRIVER

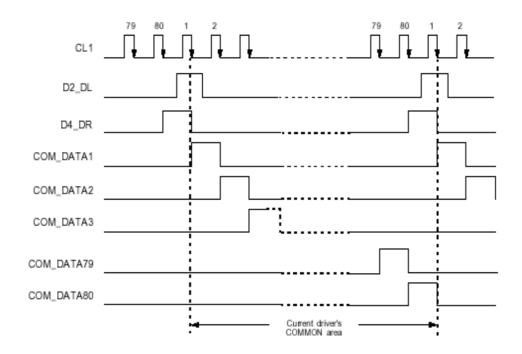
When SHL = "Low"



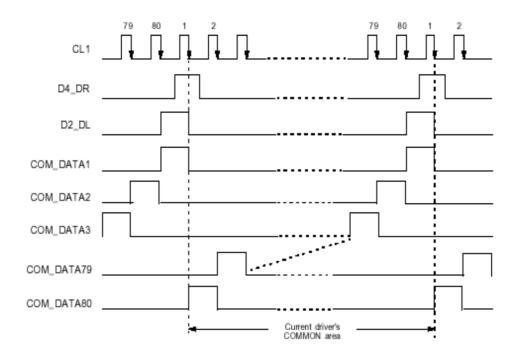


SINGLE-TYPE INTERFACE MODE COMMON DRIVER

When SHL = "Low"



When SHL = "Low"





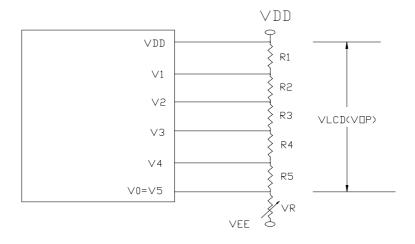
• Pin assignment

JP3:

Pin NO.	Symbol	Function	I/O
1	D0		I/O
2	D1	D D	I/O
3	D2	Data Bus	I/O
4	D3		I/O
5	/DISPOFF	H:ON L:OFF	I
6	FLM	First LINE MARKER	I
7	NC	/	/
8	LP	LATCH PULSE	
9	СР	DATA SHIFT2	I
10	VDD	POWER SUUPLY FOR LOGIC	P
11	VSS	GND	P
12	VEE	POWER SUUPLY FOR LCD	P
13	V0	OPERATING VOLTAGE LCD DRIVING	
14	FG	FRAME GROUND	
15	X1	TOUCH PANEL LOW SIGNAL IN Y AXIS	I/O
16	X2	TOUCH PANEL UPPER SIGNAL IN Y AXIS	I/O
17	Y1	TOUCH PANEL RIGHT SIGNAL IN X AXIS	I/O
18	Y2	TOUCH PANEL LEFT SIGNAL IN X AXIS	I/O
19	NC	/	/
20	A	ANODE of LED UNIT	/
21	K	CATHODE of LED UNIT	/
22	NC	/	/
23	NC	/	/
24	NC	/	/



● LCD Driving Source(1/16 Bias)



V1=Vdd - 1/16Vlcd

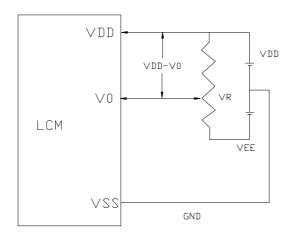
V2= Vdd - 2/16Vlcd

V3=Vdd - 14/16Vlcd

V4= Vdd - 15/16Vlcd

V5= Vdd - Vlcd

Dual Supply Voltage Types



Vdd-V0: LCD Driving Voltage



Quality Units

1.Quality level

1.1 Inspection conditions

1.1.1The environmental conditions for inspection shall be as follows

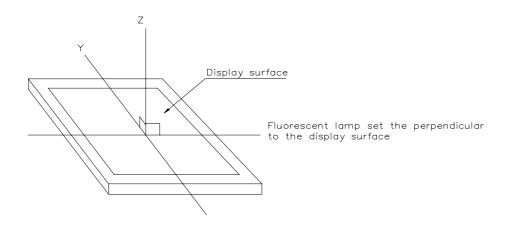
Room temperature: 22±5℃

Humidity: 65±20%RH

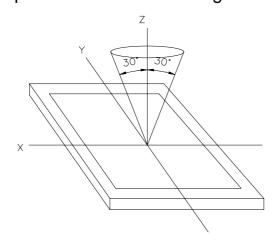
1.1.2 The external visual inspection

The inspection shall be performed by using a single 20W fluorescent lamp for illumination and the distance from LCD to eyes of the inspector should be 30±5cm.

1.1.3 Light method



1.1.4 Inspection distance and angle





Inspection should be performed within $\Phi(\Phi)$ is usually 30°) from Z axis to each X and Y axis.

Inspection distance of any direction within Φ must be kept 30±5cm to the display surface.

1.2 Sampling procedures for each item's acceptance level table

Defect type Sampling procedures		AQL
Major defect	Major defect GB2828-87 single sampling plans for normal inspection.	
Minor defect	GB2828-87 single sampling plans for normal inspection.	1.5

1.3 Classification of defects

1.3.1 Major defect

A major defect refers to a defect that is considered to substantially degrade usability for product applications.

1.3.2 Minor defect

A minor defect refers to a defect that is not considered to substantially degrade product application, or a defect that deviates from existing standards almost unrelated to the effective use of the product or its operation

2. Nonconforming Analysis and Deal With Manner

2.1 Nocconforming analysis

- (1)Customer should supply the detail data of nonconforming sample and the non-suitable sample.
- (2)After accepting detail data non-suitable sample from customer, the analysis of nonconforming should be finished in two weeks.

2.2 Deal with nonconforming

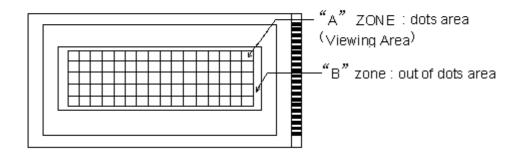
(1)Both supplier and customer should analyze the reason together and discuss the disposition of nonconforming when the reason of



nonconforming is not sure.

- 3. Standard of The Product Appearance Test
 - 3.1 manner of appearance test
 - (1)The test must be under 20w*2 or 40w fluorescent light ,and the distance of view must be at 30 cm.
 - (2)When test the model of transmissive product must add the reflective plate.
 - (3)The test direction is base on about around 45° of vertical line.

(4) Definition of area:



A area: dots area.

B area: out of dots area.(outside dots area)

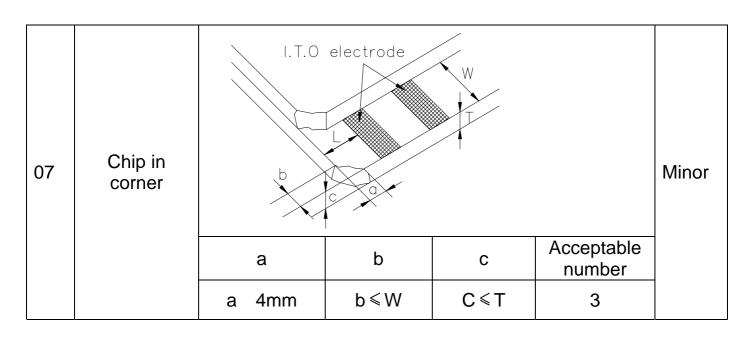
- 3.2 basic principle:
 - (1)it will accord to the AQL when the standard can not be described.
- (2)the sample of the lowest acceptable quality level must be discussed by both supplier and customer when any dispute happened.
- (3)must add new item on time when it is necessary.
- 3.3 standard of inspection (unit:mm)



NO	Itms			erion of d				AQL	
01	Electrical te	sting	No Cur spe LCE Mixe	Display,Dirent cor cifications	nsumptions; angle defect t types;	splay malfunction; nsumption exceeds product; angle defect; t types;			
02	Black or wl spots on LCD(displationly)		,no pres	more that sent.	an three	white or	y 0.25mm black spots within 3mm.	Minor	
	LCD black or white spo	ots.	†	A+B)/2	Size D(m		Acceptable number		
	(non-display	/)		В	D ≤ 0.15		Ignore	†	
		contamination (non-display)			0.15 D	≤ 0.20	3	Minor	
					0.20 D	≤ 0.25	2		
					0.25 D	≤ 0.30	1		
	Dork lines			Width (m	nm)	Length (mm)	Acceptabl e number		
	Dark lines and			W ≤ 0.03	3	L ≤ 3.0	3		
04	scratches		.¥ w	0.03 W	/ ≤ 0.05	L ≤ 2.0	2	Minor	
		→ .	/ ♣ <u>'''</u> ◀ —	0.05 W	/ ≤ 0.08	L ≤ 2.0	1		
		L		0.08 W	/ ≤0.1	L ≤ 3.0	0		
				0.1 W		L>3.0	0		
		Size D) (mn	(mm)			table number		
	bubble in	D ≤ 0.2	20			Ignore	Ignore		
05	bubble in polarizer	0.20	D ≤ (0.40			3		
		0.40	D ≤ (0.60			2		
		0.60	D				0		



		(1)Dot type	
06	Display Pattern		Minor
		Unit: mm (A+B)/2 ≤ 0.25 C ≥ 0 (D+E)/2 ≤ 0.25 (F+G)/2 ≤ 0.25 Note: 1) Acceptable up to 3 damages. 2) If there're two or more pinholes per digit, it is rejected.	





08	Chip in seal area	VIEWING AREA W				
		а	b	С	Acceptable number	
		a 3mm	b ≤ 1.5mm	c ≤ 1/2T	3	
			table, if c is ss or the seal		nan 50% of the maged.	
09 Chip i pad(1)		b		W		Minor
		а	b	С	Acceptable number	
		a≤2mm	b ≤ W/4	c≤T	ignore	
		a≤3mm	b ≤ W/4	c≤T	3	



10 Chip in pad(2)						Minor
		а	b	С	Acceptable number	
		a≤2mm	b ≤ W/3	c≤T	ignore	
		a ≤ 4mm	b ≤ W/2	c≤T	3	
11	Chip in other sides	a b b Acceptable number			Minor	
		a≤3mm	b ≤ 1mm	c≤T	ignore	
		a ≤ 4mm	b ≤ 1.5mm	c≤T	3	
12	Glass rest				Minor	
			a ≤ 1/4W			



	1		
		1. lumimation source flikers when it.	0.65
		2. Spots or scratches that apper when lit must be	1.5
		judged using LCD spot,lines and contamination	
13	Black light	standards.	
. 5 Diagni light	3. Backlight doesn't light or color is wrong.	0.65	
		4. Colour and luminance of backlight isn't	0.65
	permission to exceed criterion that customer		
		affirmed.	
		1. COB seal may not have pinholes larger than	Minor
		0.2mm or contamination.	
		2 COB seal surgace may not have pinholes	Minor
		through to the IC	
		3. The height of the COB should not exceed the	Major
		height indicated in the assembly diagram.	
		4. There may not be more than 2mm of sealant	Minor
		outside the seal area on the PCB.And there	
	DOD	should be no more than three places.	Minor
14	PCB	5. No oxidation or contamination PCB terminals.	Minor
	СОВ	6. Parts on PCB must be the same as on the	Major
		production charactersitic chart. There should	
		be no wrong parts,,,missing partsor excess	Minor
		parts.	IVIIIIOI
		7. The jumper on the PCB should conform to the	Major
		product characteristic chart.	iviajoi
		8. If solder gets on bezel tab pads,	
		LED pad,zebra pad or screw hole pad,make sure	
		it is smoothed down.	
		1. No unmelted solder paste may be present on	Minor
		the PCB.	
15	Soldering	2. No cold solder joints, missing solder	Minor
15		connections, oxidation or icile.	
		3. No short circuits in components on PCB.	Minor
		4. No short cicuits in components on PCB.	Major
		1. No oxidation,contamiation,curves or, bends on	Minor
		interface Pin or TCP.	
	General appearance	2. No cracks on interface pin of TCP.	Major
16		3. No contamination solder residue or solder balls	Minor
		on product.	
		4. The IC on the TCP may not be damaged,	Mino
		circuits.	r



5.	The uppermost dege of the protective strip on the interface pin must be present or look as if it cause the interface pin to sever.	Minor
6.	The residual rosin or tin oil of sldering (component or chip component) is not burned into brown or black color.	Minor
7、	Sealant on top of the ITO circuit has not hardeed.	Minor
8.	Pin type must match type in specification sheet.	
9、	LCD pin loose or missing pins.	Major
10.	Product packaging must the same as specified on packaging specification sheet.	Major Major
11、	Product dimension and structure must conform to product specification sheet.	Major
12、	The appearance of Heat Seal should not admit any dirt and break.	Major

3. Standard specification for reliability of LCD Module

ITEM	Condition	Criterion
1)High	50 ℃	Total current consumption
temperature	24h	should be below double of
operating		initial value.
2)Low	-30℃	Cosmetic defects should not
temperature	8h	be happened.
operating		
3)Humidity(witho	40℃ 90%RH 240hours	
ut polarizer)	40 C 30 /01(11 240110013	
4)High	60℃	
temperature	16hours	
storage		
5)Low	-10℃	
temperature	8hours	
storage		
6)Thermal shock	-20°C →25°C →70°C →25°C	
storage	30min 5min 30min	
	5min	
	5cycle	



7)Vibration (package state)	10 ~ 150Hz 5m/s ² 45min		
8)Shock test (package state)	50Hz amplitude :0.7mm 30min for each direction (X.Y.Z)		